

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10676067	MATSUEDA ET AL.
	Examiner Duong, Dieu Hien T	Art Unit 2821

SEARCHED

Class	Subclass	Date	Examiner
315	169.2,169.3	11/20/06	dd

SEARCH NOTES

Search Notes	Date	Examiner
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INTERFERENCE SEARCH

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